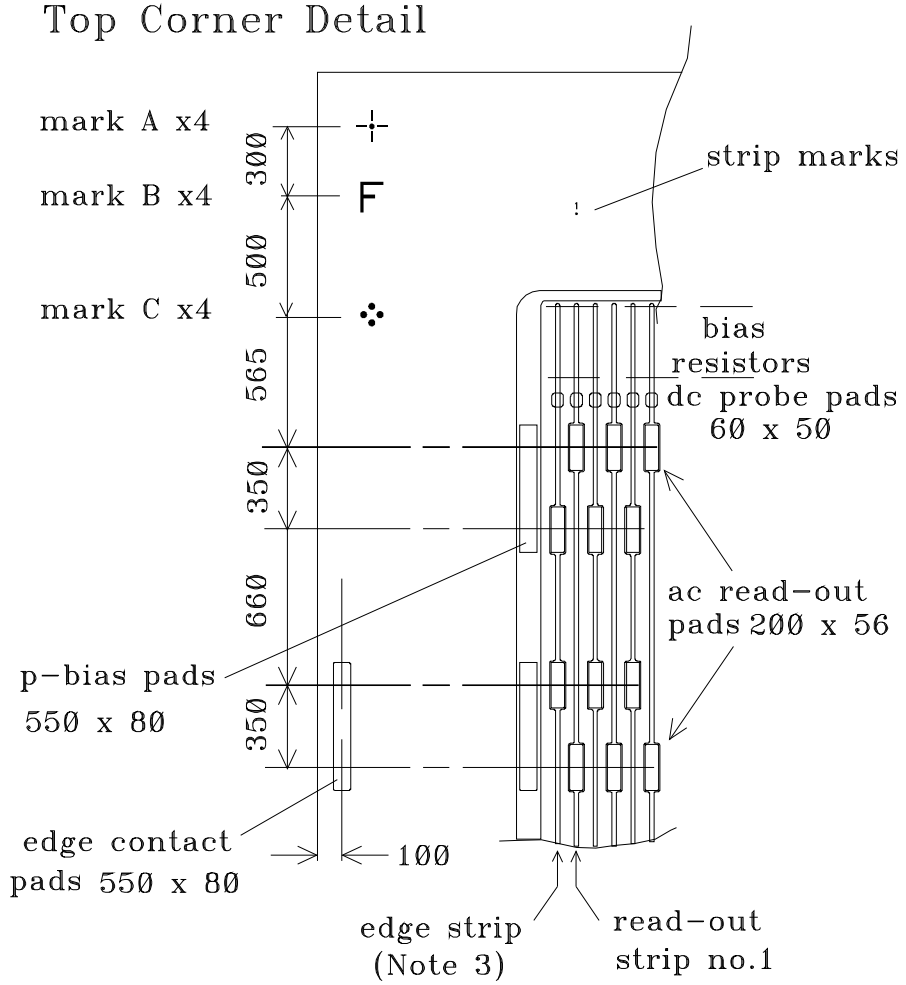
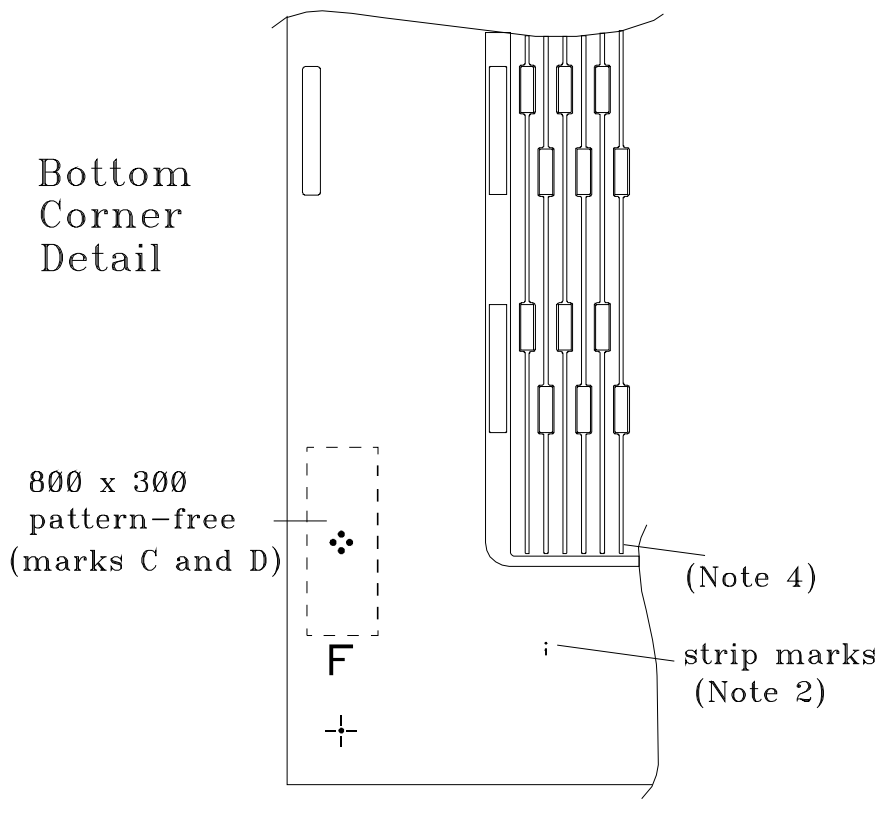
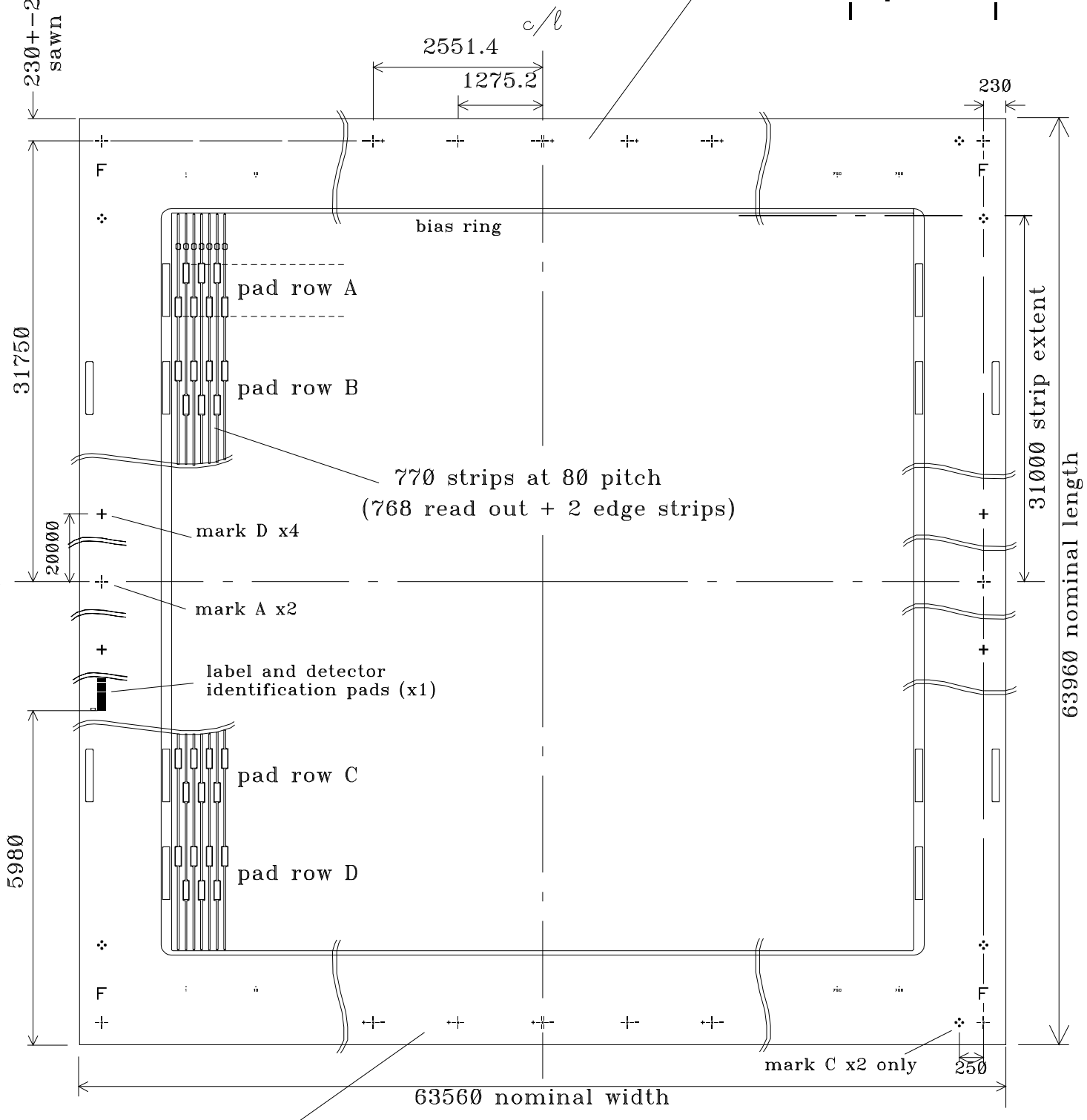
Top Corner Detail

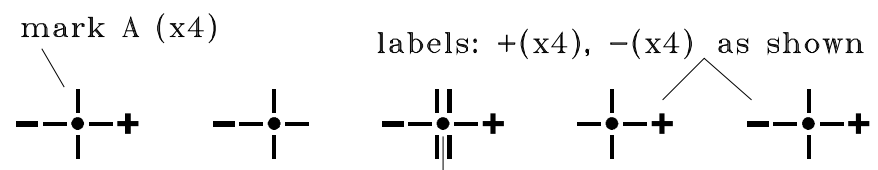


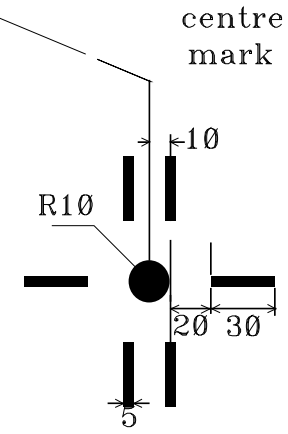
Bottom Corner Detail



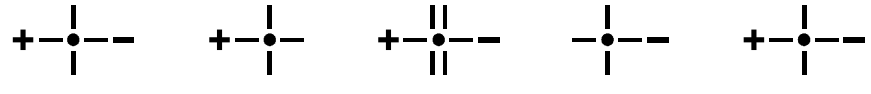


Stereo Alignment pattern (5 marks):





Stereo Alignment pattern 180 degrees rotated:



NOTES:

1. Marks, label and scratch pads detailed in drg: "ATLAS SCT Alignment/ID marks"

2. Omit individual strip marks in cases of conflict with alignment marks

3. Edge strips may be identical to strips 1-768. Alternatively, implant and metal may be d.c. connected to bias ring (omitting read-out pads) and p-bias pad optionally located between strip and bias ring.

4. Option of additional row of dc probe pads at strip end.

5. Guard structure (not shown) should be provided with probe pads.

Title	Version	Date	Drawn by (Cadence)	Checked by	Dimensions	Tolerances	Scale	Amended
ATLAS SCT BARREL	003	19 DEC.2000	G.A.Beck, QMW	D.R.	μm	Lithographic: +- 3μm Sawn: +-25μm	NOT TO SCALE	